

# MOSFET - Power, Single N-Channel

## 100 V, 1.7 mΩ, 273 A

NTMTS1D6N10MC

### Features

- Small Footprint (8x8 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- New Power 88 Package
- These Devices are Pb-Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	100	V
Gate-to-Source Voltage	Э		V <sub>GS</sub>	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	273	Α
Current R <sub>θJC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C		193	
Power Dissipation	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	291	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C	1	146	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	36	Α
Current R <sub>0JA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C	1	25	
Power Dissipation	State	T <sub>A</sub> = 25°C	$P_{D}$	5	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C	1	2.5	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			Is	243	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 22.3 A)			E <sub>AS</sub>	1301	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

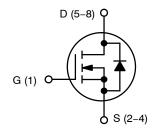
#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.5	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	30	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

1

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
100 V	1.7 m $\Omega$ @ 10 V	273 A



**N-CHANNEL MOSFET** 

#### DFNW8 CASE 507AP

#### MARKING DIAGRAM

0 1D6N10MC AWLYWW

1D6N10MC = Specific Device Code

A = Assembly Location
WL = Wafer Lot Code
Y = Year Code
W = Work Week Code

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

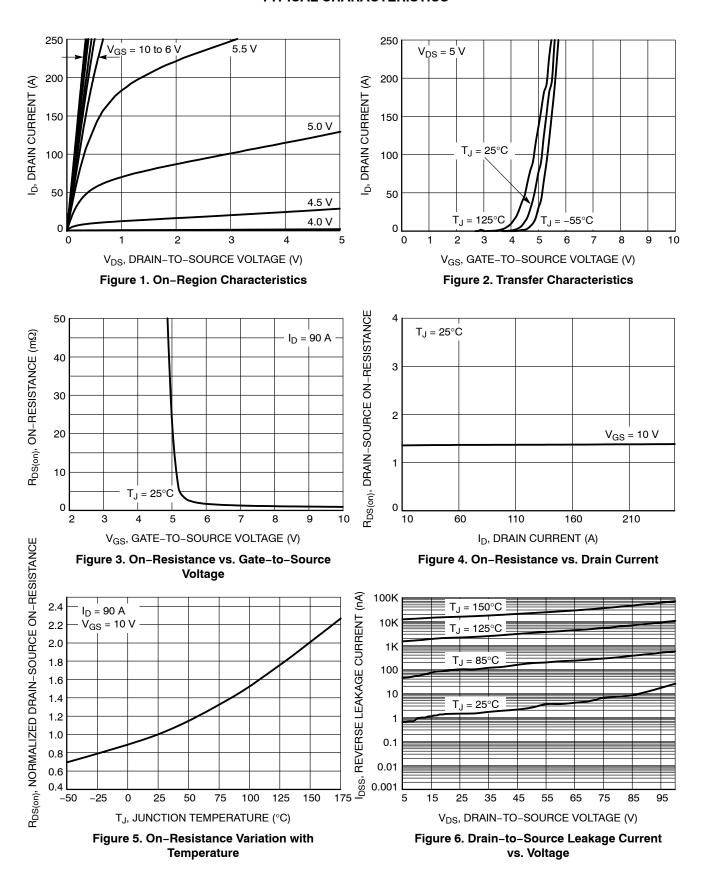
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				64.5		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			1.0	
		V <sub>DS</sub> = 100 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	; = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 650 μΑ	2.0		4.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-10		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 90 A		1.42	1.7	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> =5 V, I <sub>D</sub> =	100 A		233		S
CHARGES, CAPACITANCES & GATE RESI	STANCE						-
Input Capacitance	C <sub>ISS</sub>				7630		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 100 KH	Hz, V <sub>DS</sub> = 50 V		4260		рF
Reverse Transfer Capacitance	C <sub>RSS</sub>	]			80		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 116 A			106		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 116 A			20		
Gate-to-Source Charge	$Q_{GS}$				35		
Gate-to-Drain Charge	$Q_{GD}$				22		
Plateau Voltage	$V_{GP}$				5		V
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t <sub>d(ON)</sub>				34		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub>	s = 50 V,		24		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{D} = 116  A,  R_{G}$	= 6 Ω		69		
Fall Time	t <sub>f</sub>				29		
DRAIN-SOURCE DIODE CHARACTERISTI	cs						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.83	1.2	
		I <sub>S</sub> = 90 A	T <sub>J</sub> = 125°C		0.7		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 58 \text{ A}$			54		
Charge Time	ta				26		ns
Discharge Time	t <sub>b</sub>				28		
Reverse Recovery Charge	$Q_{RR}$				52		nC
Reverse Recovery Time	t <sub>RR</sub>				43		
Charge Time	ta	V <sub>GS</sub> = 0 V, dIS/dt =	1000 A/μs,		23		ns
Discharge Time	t <sub>b</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 1000 \text{ A/}\mu\text{s,}$ $I_{S} = 58 \text{ A}$			19		
Reverse Recovery Charge	Q <sub>RR</sub>				385		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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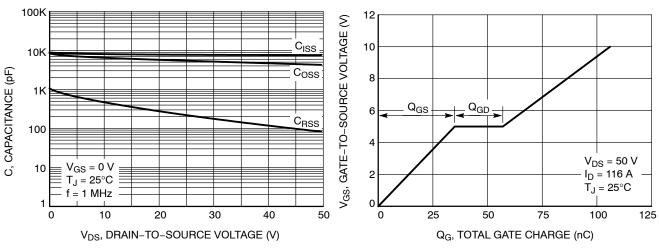


Figure 7. Capacitance Variation



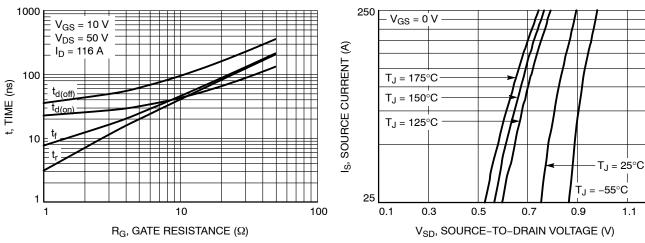


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

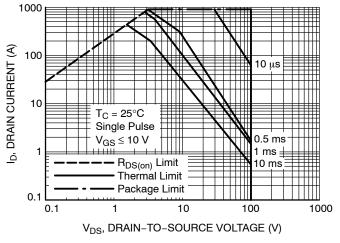


Figure 11. Safe Operating Area

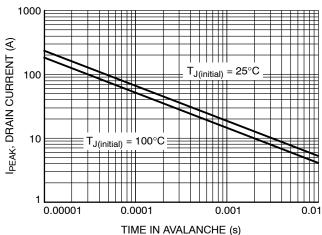


Figure 12. Maximum Drain Current vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

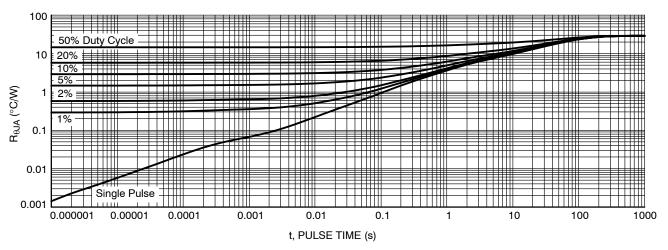


Figure 13. Junction-to-Ambient Transient Thermal Response

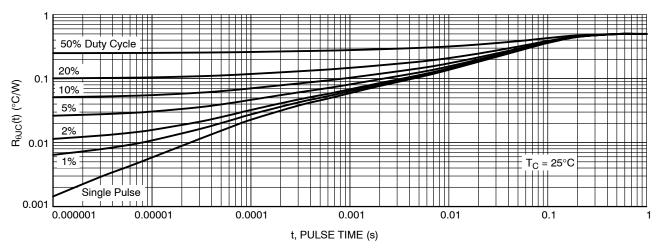


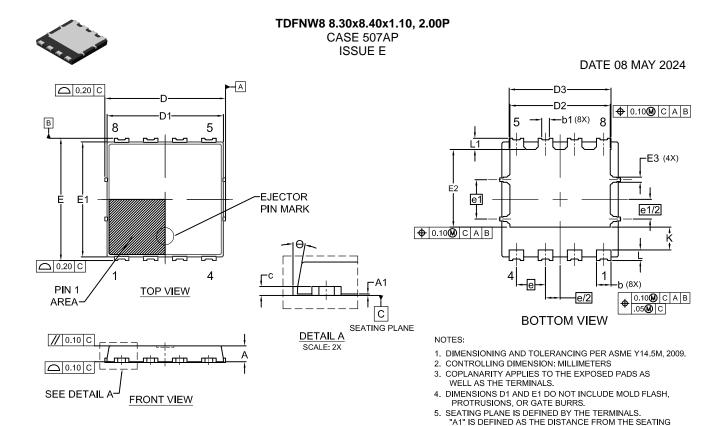
Figure 14. Thermal Response

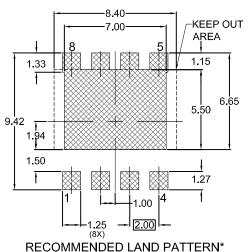
#### **DEVICE ORDERING INFORMATION**

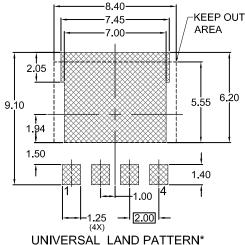
Device	Marking	Package	Shipping <sup>†</sup>
NTMTS1D6N10MCTXG	1D6N10MC	POWER 88 (Pb–Free)	3,000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.









DIM	MILLIMETERS			
Divi	MIN.	MAX.		
Α	1.00	1.10	1.20	
A1	0.00	-	0.05	
b	0.90	1.00	1.10	
b1	0.35	0.45	0.55	
O	0.23	0.28	0.33	
D	8.20	8.30	8.40	
D1	7.90	8.00	8.10	
D2	6.80	6.90	7.00	
D3	6.90	7.00	7.10	
Е	8.30	8.40	8.50	
E1	7.80	7.90	8.00	
E2	5.24	5.34	5.44	
E3	0.25	0.35	0.45	
е		2.00 BS	С	
e/2		1.00 BS	С	
e1		2.70 BSC		
e1/2	1.35 BSC			
K	1.50	1.57	1.70	
Г	0.64	0.74	0.84	
L1	0.67	0.77	0.87	
θ	0°		12°	

PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE	
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THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES	
REFERENCE MANUAL, SOLDERRM/D.	

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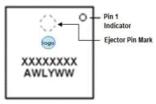
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#### TDFNW8 8.30x8.40x1.10, 2.00P

CASE 507AP ISSUE E

**DATE 08 MAY 2024** 

### GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot Code
Y = Year Code
WW = Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

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